

SK50GARL065F



SEMISTOP[®] 2

IGBT Module

SK50GARL065F

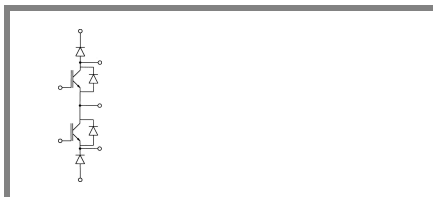
Preliminary Data

Features

- Compact design
- One screw mounting
- Heat transfer and isolation through direct copper bonded aluminium oxide ceramic (DCB)
- N-channel homogeneous silicon structure (NPT-Non punch-through IGBT)
- Low tail current with low temperature dependence
- Low threshold voltage
- Fast Turbo diode

Typical Applications

- Switching (not for linear use)
- Inverter
- Switched mode power supplies
- UPS



GARL

Absolute Maximum Ratings		$T_s = 25\text{ °C}$, unless otherwise specified			
Symbol	Conditions	Values		Units	
IGBT					
V_{CES}	$T_j = 25\text{ °C}$	600		V	
I_C	$T_j = 125\text{ °C}$	$T_s = 25\text{ °C}$	54		A
		$T_s = 80\text{ °C}$	40		A
I_{CRM}	$I_{CRM} = 2 \times I_{Cnom}$	120		A	
V_{GES}		± 20		V	
t_{psc}	$V_{CC} = 300\text{ V}; V_{GE} \leq 20\text{ V}; T_j = 125\text{ °C}$ $V_{CES} < 600\text{ V}$	10		µs	
Inverse Diode					
I_F	$T_j = 150\text{ °C}$	$T_s = 25\text{ °C}$	25		A
		$T_s = 80\text{ °C}$	17		A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$			A	
I_{FSM}	$t_p = 10\text{ ms}; \text{half sine wave } T_j = 150\text{ °C}$	100		A	
Freewheeling Diode					
I_F	$T_j = 150\text{ °C}$	$T_{case} = 25\text{ °C}$	82		A
		$T_{case} = 80\text{ °C}$	50		A
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$	120		A	
Module					
$I_{t(RMS)}$				A	
T_{vj}		-40 ... +150		°C	
T_{stg}		-40 ... +125		°C	
V_{isol}	AC, 1 min.	2500		V	

Characteristics		$T_s = 25\text{ °C}$, unless otherwise specified				
Symbol	Conditions	min.	typ.	max.	Units	
IGBT						
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 0,7\text{ mA}$	3	4	5	V	
I_{CES}	$V_{GE} = 600\text{ V}, V_{CE} = V_{CES}, T_j = 25\text{ °C}$			0,0022	mA	
I_{GES}	$V_{CE} = 0\text{ V}, V_{GE} = 20\text{ V}, T_j = 25\text{ °C}$			120	nA	
V_{CE0}		$T_j = 25\text{ °C}$	1,2	1,3	V	
		$T_j = 125\text{ °C}$	1,1	1,2	V	
r_{CE}	$V_{GE} = 15\text{ V}$	$T_j = 25\text{ °C}$			12	mΩ
		$T_j = 125\text{ °C}$			22	mΩ
$V_{CE(sat)}$	$I_{Cnom} = 60\text{ A}, V_{GE} = 15\text{ V}$	$T_j = 25\text{ °C}_{chiplev.}$	1,7	2	V	
		$T_j = 125\text{ °C}_{chiplev.}$	2,2	2,2	V	
C_{ies}	$V_{CE} = 25, V_{GE} = 0\text{ V}$			3,2	nF	
C_{oes}				0,3	nF	
C_{res}				0,18	nF	
Q_G	$V_{GE} = 0 \dots 20\text{ V}$			368	nC	
$t_{d(on)}$	$R_{Gon} = 15\text{ Ω}$	$V_{CC} = 300\text{ V}$ $I_{Cnom} = 40\text{ A}$			47	ns
t_r					40	ns
E_{on}					1,03	mJ
$t_{d(off)}$	$R_{Goff} = 15\text{ Ω}$	$T_j = 125\text{ °C}$ $V_{GE} = \pm 15\text{ V}$			203	ns
t_f					33	ns
E_{off}					0,8	mJ
$R_{th(j-s)}$	per IGBT			0,85	K/W	



SEMITOP[®] 2

IGBT Module

SK50GARL065F

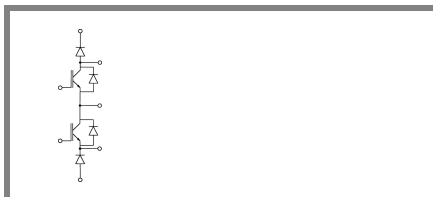
Preliminary Data

Features

- Compact design
- One screw mounting
- Heat transfer and isolation through direct copper bonded aluminium oxide ceramic (DCB)
- N-channel homogeneous silicon structure (NPT-Non punch-through IGBT)
- Low tail current with low temperature dependence
- Low threshold voltage
- Fast Turbo diode

Typical Applications

- Switching (not for linear use)
- Inverter
- Switched mode power supplies
- UPS

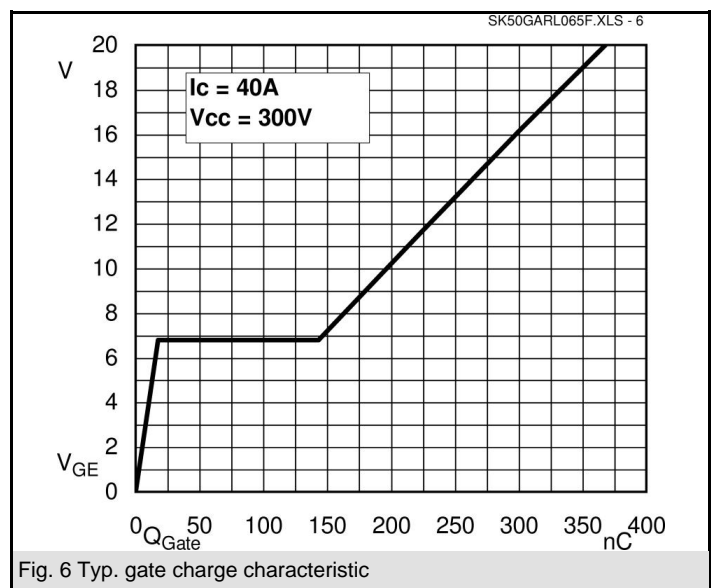
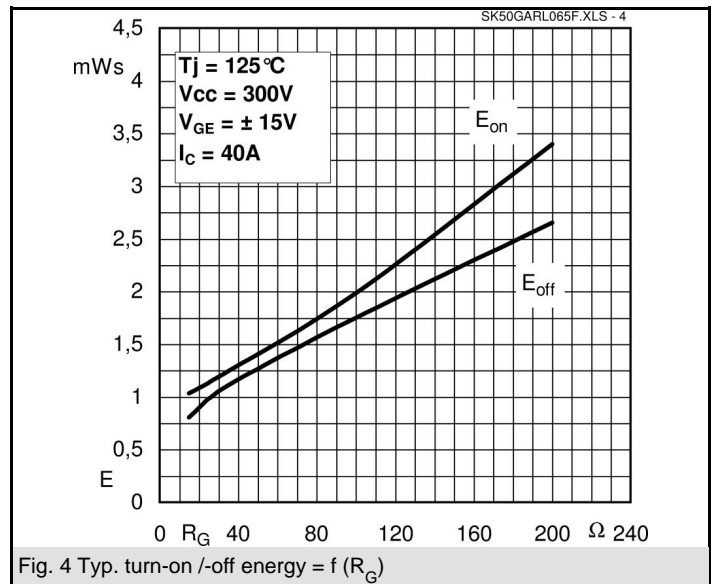
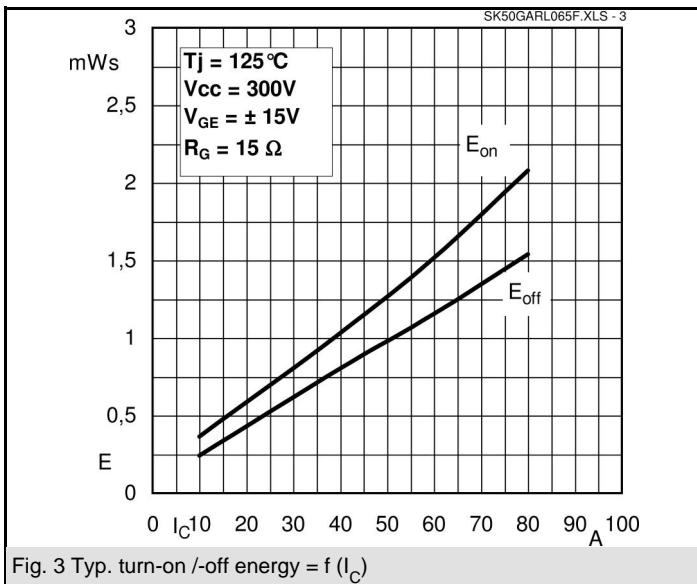
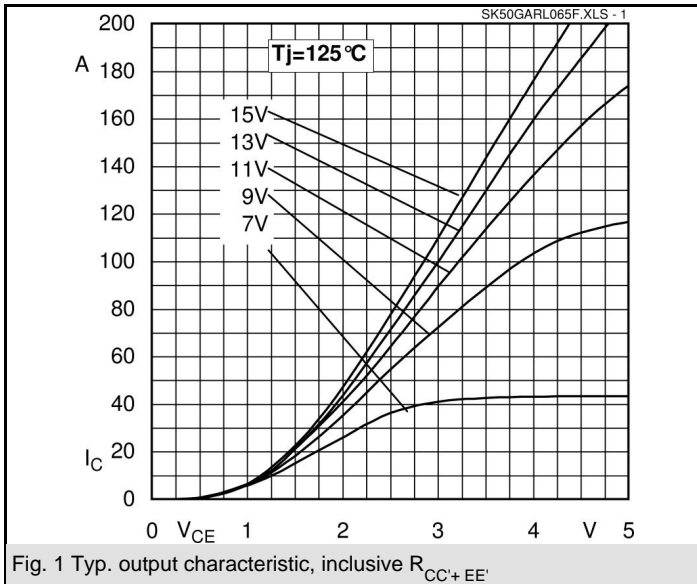


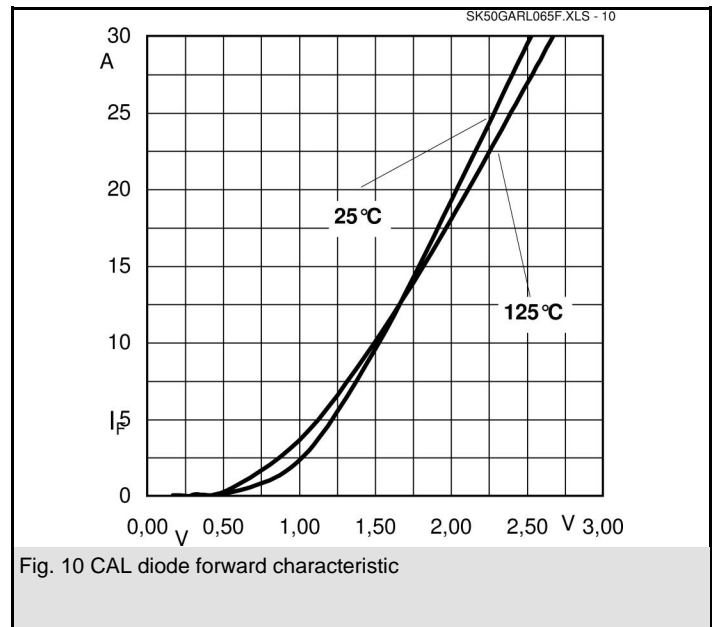
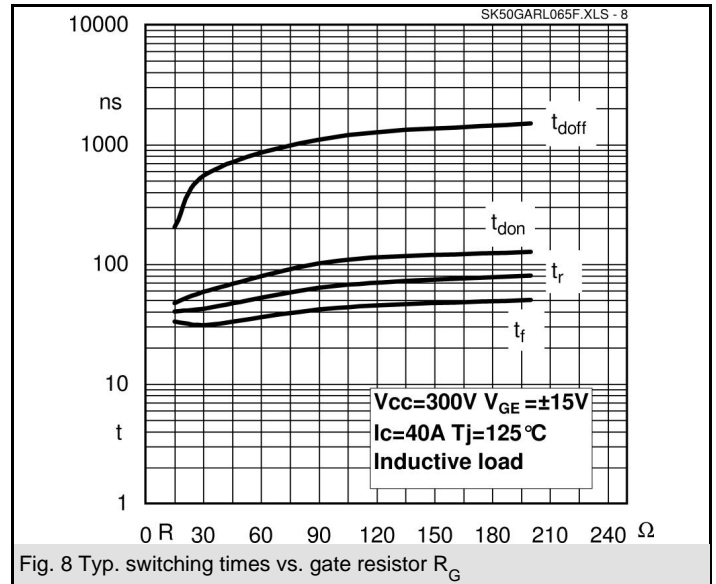
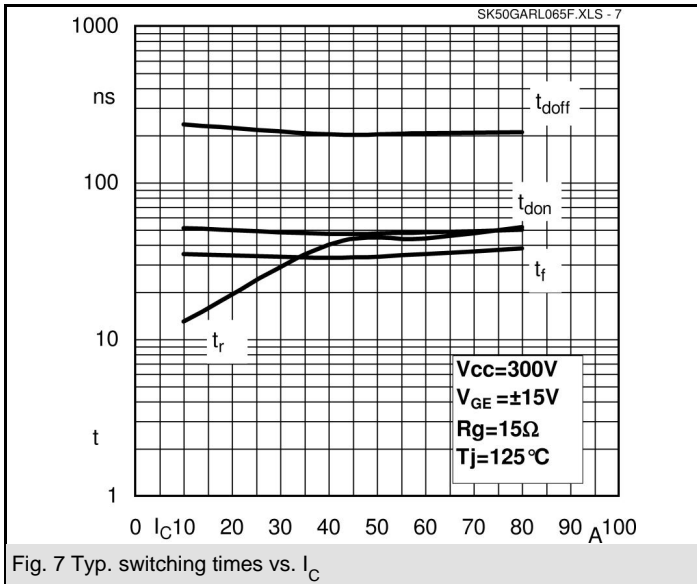
GARL

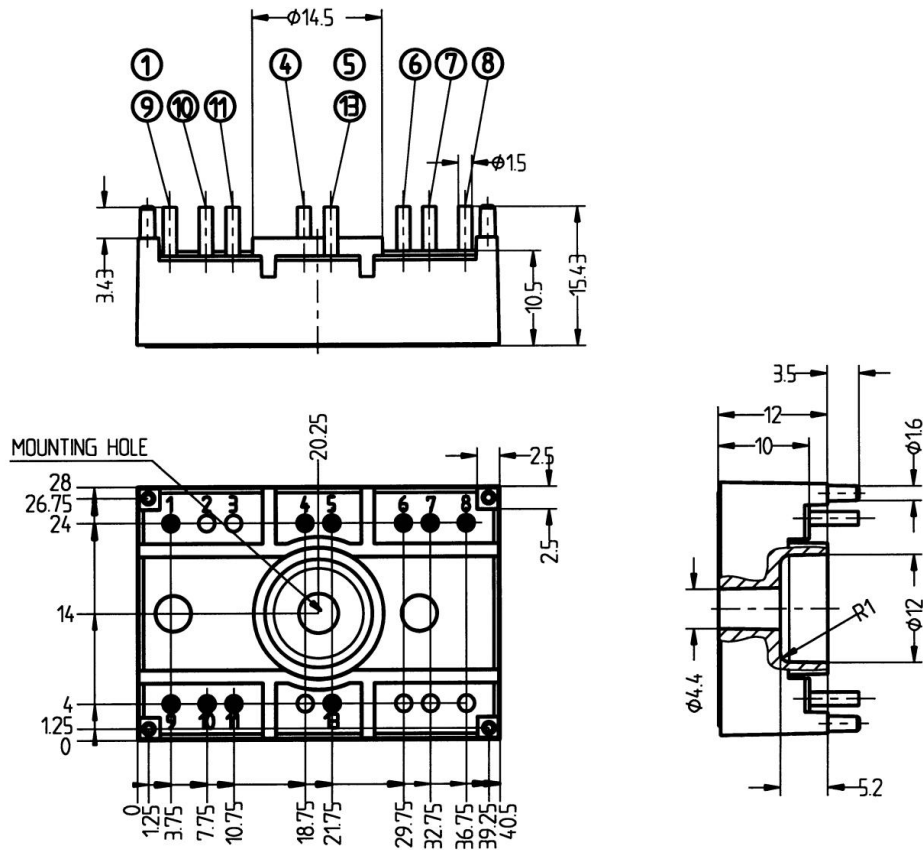
Characteristics					
Symbol	Conditions	min.	typ.	max.	Units
Inverse Diode					
$V_F = V_{EC}$	$I_{Fnom} = 15 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25 \text{ }^\circ\text{C}_{\text{chiplev.}}$	1,4	1,7	V
		$T_j = 125 \text{ }^\circ\text{C}_{\text{chiplev.}}$	1,4	1,7	V
V_{F0}		$T_j = 125 \text{ }^\circ\text{C}$	0,9	1	V
r_F		$T_j = 125 \text{ }^\circ\text{C}$	33	47	mΩ
I_{RRM} Q_{rr} E_{rr}	$I_{Fnom} = 30 \text{ A}$ $di/dt = 500 \text{ A}/\mu\text{s}$ $V_{CC}=300\text{V}$	$T_j = 125 \text{ }^\circ\text{C}$			A μC mJ
$R_{th(j-s)D}$	per diode			2,3	K/W
Freewheeling diode					
$V_F = V_{EC}$	$I_{Fnom} = 60 \text{ A}; V_{GE} = 0 \text{ V}$	$T_j = 25 \text{ }^\circ\text{C}_{\text{chiplev.}}$	1,1	1,6	V
		$T_j = 150 \text{ }^\circ\text{C}_{\text{chiplev.}}$		1,25	V
V_{F0}		$T_j = 150 \text{ }^\circ\text{C}$	0,85		V
r_F		$T_j = 150 \text{ }^\circ\text{C}$	7		V
I_{RRM} Q_{rr} E_{rr}	$I_{Fnom} = 50 \text{ A}$ $di/dt = -1000 \text{ A}/\mu\text{s}$ $V_R=300\text{V}$	$T_j = 125 \text{ }^\circ\text{C}$	38		A μC mJ
$R_{th(j-s)D}$	per diode			1,1	K/W
M_s	to heat sink		1,8	2	Nm
w			19		g

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

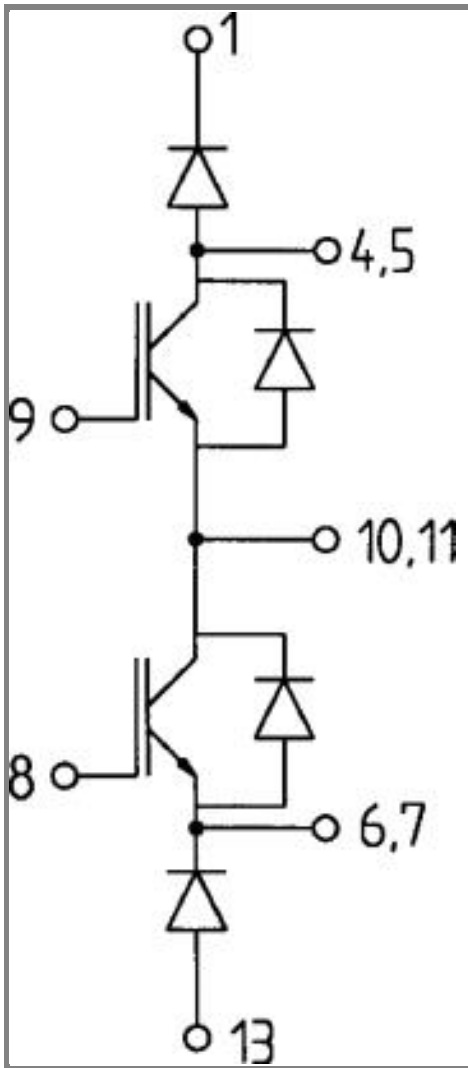
This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.







Case T31 (Suggested hole diameter, in the PCB, for solder pins and plastic mounting pins: 2mm)



Case T31

GARL